## Applicant(s)/Patent Under Application/Control No. Reexamination 10/501.080 YOSHIDA, HIROSHI Notice of References Cited Examiner Art Unit Page 1 of 1 Chuong A. Luu 2818 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D Ε US-US-F US-G US-Ĥ USſ US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY EP0502471 A2 03-1992 Japan Shirakawa et al. Ν 0 Ρ Q R s Ţ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.